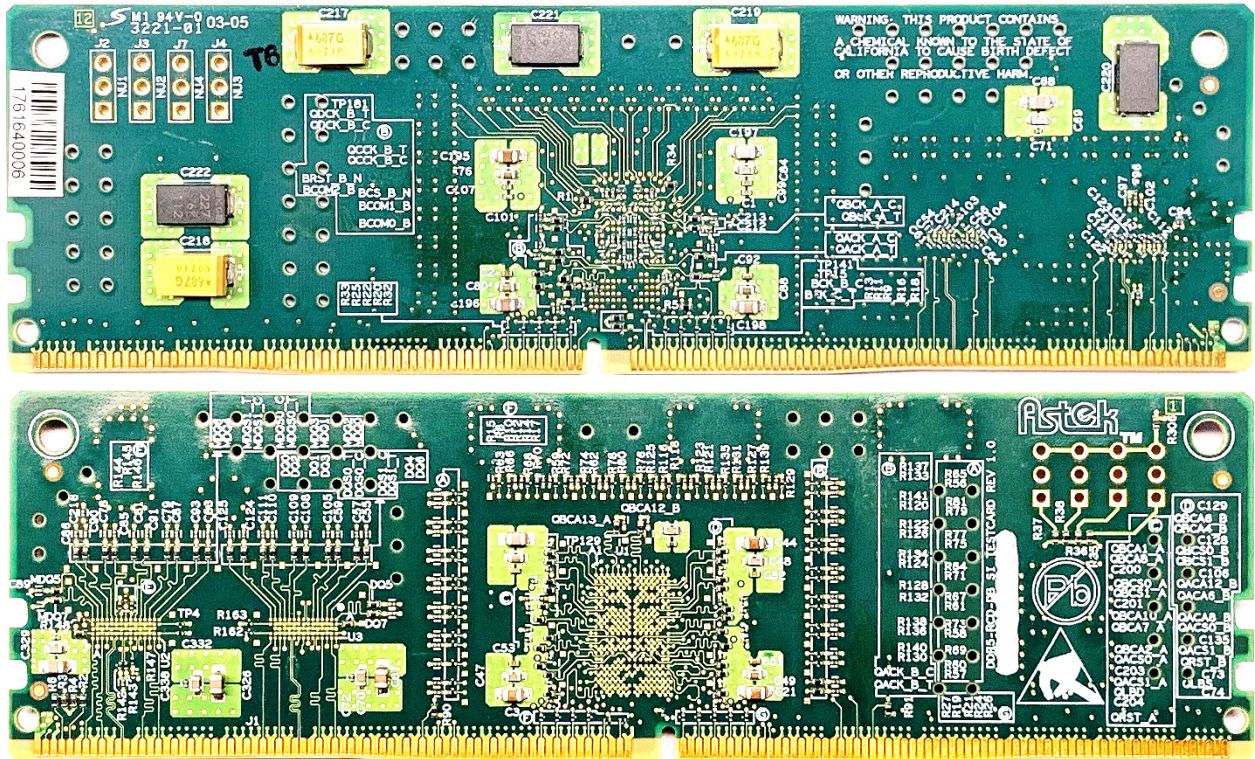


A9-SIT-01

Product Brief



Transforming Technology
into Customer Value



DDR5 RCD Signal Integrity Card

A versatile DIMM test card focused on RCD and Data Buffer Signal Integrity (SI) measurement. It Minimizes signal integrity impact by using JEDEC reference load termination in combination with minimal trace lengths. Provides high impedance oscilloscope probing access to QA_A, QB_A, QA_B, QB_B and BCOMM outputs of the RCD under test, as well as DQ[S] and MDQ[s] outputs of Data Buffers. RCD SI test cards are compatible with Astek's A9-CTC2.

Features

- RCD and Data Buffer test points compatible with Keysight MX0100 high performance oscilloscope probes
- Minimizes SI impact using JEDEC reference load termination

Configuration

- All critical passive Rs and Cs installed
- RCD, and Data Buffers provided by customer

Ordering Information

Model Number	Product Description
A9-SIT-01	RCD Signal Integrity Test Card

For more information, contact your Keysight sales representative or visit the Astek web site at: www.astekcorp.com